## Notice of References Cited Application/Control No. 10/540,549 Applicant(s)/Patent Under Reexamination KITAHARA ET AL. Examiner Henry S. Hu 1796 Application/Control No. Applicant(s)/Patent Under Reexamination KITAHARA ET AL.

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,237,049	08-1993	Cavanaugh et al.	528/491
*	В	US-6,680,124 B1	01-2004	Araki et al.	428/421
	U	US-			
	D	US-			
	ш	US-			
	F	US-			
	O	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	WO-2004/058833 A1	07-2004	wo	KItahara et al.	
*	0	WO-94/05706	03-1994	wo	Cavanaugh et al.	
*	Р	JP-06-080733	03-1994	JP	Akihiko et al.	
*	Ø	EP-472,908 A2	07-1991	EP	Ohtani et al.	
*	R	WO-99/45044	09-1999	wo	Araki et al.	
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.